

Notice of References Cited	Application/Control No. 10/669,666	Applicant(s)/Patent Under Reexamination BEIERLE, FRED P.	
	Examiner Jennifer A. Leung	Art Unit 1764	Page 1 of 1

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*	B	US-4,883,499	11-1989	Beierle et al.	48/203
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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